

Review

Theoretical and Experimental Aspects of Current and Future Research on NbO₂ Thin Film Devices

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Abstract: The present research front of NbO₂ based memory, energy generation, and storage thin film devices is reviewed. Sputtering plasmas contain NbO, NbO₂, and NbO₃ clusters, affecting nucleation and growth of NbO₂, often leading to a formation of nanorods and nanoslices. NbO₂ (*I4₁/a*) undergoes the Mott topological transition at 1081 K to rutile (*P4₂/mnm*), yielding changes in the electronic structure, which is primarily utilized in memristors. The Seebeck coefficient is a key physical parameter governing the performance of thermoelectric devices, but its temperature behavior is still controversial. Nonetheless, they perform efficiently above 900 K. There is a great potential to improve NbO₂ batteries since the theoretical capacity has not been reached, which may be addressed by future diffusion studies. Thermal management of functional materials, comprising thermal stress, thermal fatigue, and thermal shock, is often overlooked even though it can lead to failure. NbO₂ exhibits relatively low thermal expansion and high elastic modulus. The future for NbO₂ thin film devices looks promising, but there are issues that need to be tackled, such as dependence of properties on strain and grain size, multiple interfaces with point and extended defects, and interaction with various natural and artificial environments, enabling multifunctional applications and durable performance.

Keywords: NbO₂; thin films; sputtering; density functional theory; electrical properties; thermal properties; mechanical properties



Citation: Music, D.; Krause, A.M.; Olsson, P.A.T. Theoretical and Experimental Aspects of Current and Future Research on NbO₂ Thin Film Devices. *Crystals* **2021**, *11*, 217. <https://doi.org/10.3390/cryst11020217>

Academic Editor: Shujun Zhang

Received: 2 February 2021
Accepted: 20 February 2021
Published: 22 February 2021

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1. Introduction

NbO₂ (space group *I4₁/a* (distorted rutile), above 1081 K space group *P4₂/mnm* (rutile)) [1] is a binary system belonging to a common class of rutile oxides, comprising SiO₂, TiO₂, VO₂, CrO₂, MnO₂, GeO₂, NbO₂, RuO₂, RhO₂, SnO₂, TaO₂, OsO₂, IrO₂, and PbO₂ [2,3]. Even though Nb can readily form other binary oxides, such as NbO and Nb₂O₅ [1], NbO₂ is an emerging compound prone to yield many exciting cutting-edge applications. NbO₂ exhibits an amalgam of remarkable physical and chemical properties [4], including one of the highest Mott transition temperature (1081 K) [5–7], high specific capacity in Li ion batteries (up to 225 mAhg⁻¹) [8,9], large relative dielectric constant (approx. 10) [10,11], large Seebeck coefficient (order of −200 μV K⁻¹) [12–15], enhanced catalytic activity towards H₂ [16] and N₂ [17] as well as oxygen reduction reactions [18]. Moreover, further characteristics are known such as superconductivity at 5 K when intercalated with Li [19], a relatively low linear coefficient of thermal expansion (4.8 ppm K⁻¹ at 373 K) [20], and low fluence of 2 mJ cm⁻² required for optical excitations [21]. NbO₂ is identified to form different types of nanostructures, including nanorods [11] and nanoslices [10,22]. Such attractive properties give rise to many high-tech applications of NbO₂ (see Figure 1), including, but not limited to, memristors [23–25], x-point memory arrays [26], electro-optic switching [27–29], diodes and electron emitters [10,11], fuel cells [18], batteries [8,9], surface catalysis [16–18], and thermoelectric devices [14,15].

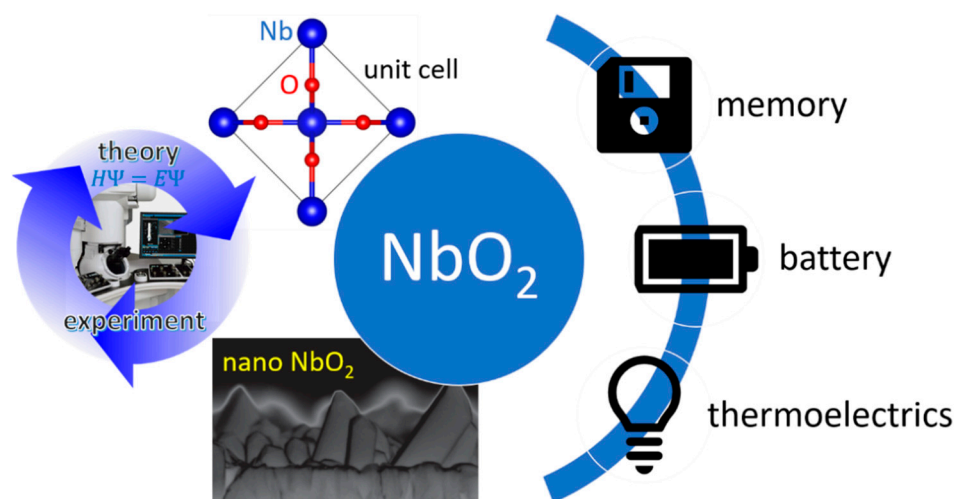


Figure 1. Synergy of theoretical and experimental methods employed on nanostructured NbO₂ to open up possibilities for many high-tech applications. This review is congregated around memory and energy thin film devices.

It is needless to say that microelectronic devices are nowadays thin films and they are also important for the majority of other applications of NbO₂ stated above. Of the two major thin film synthesis methods, physical and chemical vapor deposition, NbO₂ has been grown using the former, predominantly magnetron sputtering [13,22,27–30]. However, also pulsed laser deposition [6], electron [31] or ion [32] beam evaporation and molecular beam epitaxy [33] can be employed. In addition, NbO₂ also forms by oxidation of Nb [34], alike to oxidation of other metals related to rutile oxides such as Zr [35]. Hence, this review focuses on sputtered thin films because it is the most common synthesis route for NbO₂, it is environmentally friendly, it is relatively easy to control and it is frequently used in industry. Furthermore, sputtering offers the possibility to utilize ion-surface interactions to achieve a desired microstructure or texture and enable nanostructuring.

Density functional theory (DFT) [36,37] is a quantum mechanical method frequently used in materials science, physics, chemistry and even in biology to some extent. Through employment of such techniques, the electronic structure of a ground state can be related to physical and chemical properties, enabling predictions of novel materials and previously unknown mechanisms as well as providing insights into already identified experimental phenomena. Synergistic merging of DFT and experiments (see Figure 1) is a very potent approach to understand and advance many fields driven by applications. Hence, this review is focused on synergy aided advances of NbO₂ thin films pertaining to cutting-edge applications (see Figure 1), including memory as well as energy generation and storage devices. Transport, thermal and mechanical properties are discussed in this review with respect to the electronic structure and performance. While the importance of the electrical and thermal properties may be self-evident for the said applications of NbO₂, the mechanical properties are also of significance as secondary features, being an integral part of thermal stress, thermal fatigue, and thermal shock [38], which cannot be ignored in modern design endeavors of microelectronic, energy generation and storage devices.

2. Nucleation and Growth

Magnetron sputtering is a plasma based physical vapor deposition technique that is commonly employed to synthesize NbO₂ thin films [13,22,27–30]. Both plasma energetics and composition are relevant for surface diffusion processes governing the nucleation and growth of sputtered thin films [39]. Oxygen ions exhibit a broad energy distribution according to the analysis of Nb–O₂–Ar sputtering plasma [40]. In addition, increasing Nb oxidation states up to Nb²⁺ are observed upon increasing energy input into a sputtering target [41]. A considerable amount of plasma composition insights has been gained from

high-energy molecular beam experiments revealing that Nb can form a variety of clusters with O in the gas phase, such as NbO, NbO₂, NbO₃, Nb₂O₄, Nb₂O₅, Nb₂O₆, Nb₃O₆, Nb₃O₇, Nb₃O₈, Nb₄O₉, Nb₄O₁₀, Nb₄O₁₁, Nb₅O₁₁, Nb₅O₁₂ and Nb₅O₁₃ [42,43]. Some of these Nb containing clusters have also been detected in sputtering plasmas, namely NbO, NbO₂ and NbO₃ [44], as depicted in Figure 2. This is not common for sputtering plasmas and should affect the growth processes of NbO₂. Nb and clusters containing Nb on NbO₂(001) surface exhibit strong adsorption (adsorption energies in the order of -7.2 to -10.1 eV) [44]. These species are not very mobile, but if there is any surface diffusion, it occurs along the $\langle 110 \rangle$ direction, characterized by hopping from one lattice site to another [44]. By tuning the plasma composition (O₂ partial pressure) to prevent the formation of NbO₃ clusters, unwanted NbO clusters are still present when synthesizing NbO₂ thin films [44]. This may lead to a growth disruption and recurring nucleation. However, even though high crystalline quality may be challenging to achieve under such conditions, this may be of relevance for nanostructuring, which is discussed below. It is interesting to remark that the NbO₂ clusters in an amorphous Nb–O matrix are energetically more stable than the NbO clusters by 44 meV atom^{-1} [45], giving rise to stable nuclei and formation of NbO₂.

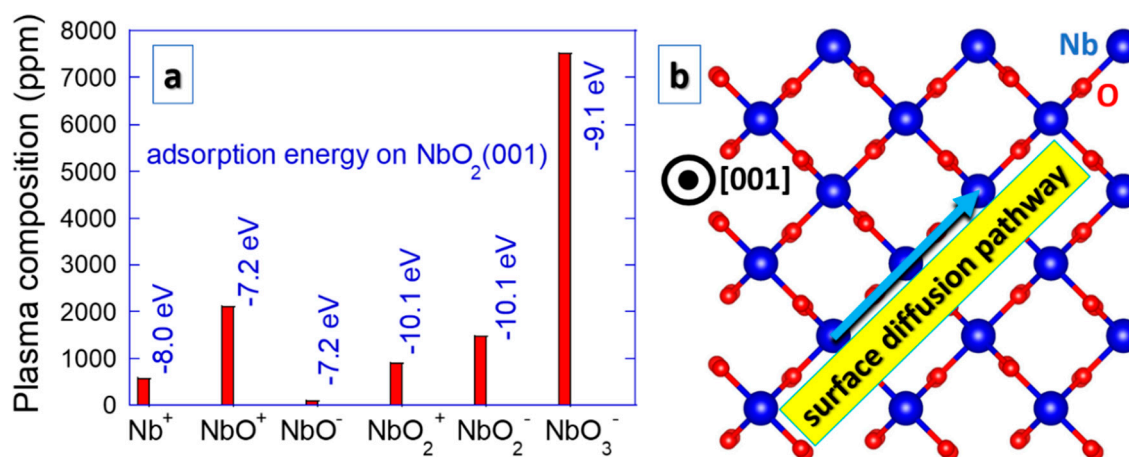


Figure 2. Composition of Nb–O₂–Ar sputtering plasma regarding Nb containing species [44] (a). Adsorption energies on NbO₂(001) surfaces (a) are provided together with a predominant diffusion pathway [44] (b).

Once stable NbO₂ nuclei form in an amorphous matrix or (epitaxially) on a suitable substrate, thin film growth proceeds and the microstructure evolves. Commonly, thin films grow in a columnar (3D) manner, but a layer-by-layer (2D) growth is also possible [39]. Typically, sputtered NbO₂ thin films are not epitaxial (2D), unlike samples obtained by pulsed laser deposition [6] or molecular beam epitaxy [46]. This may be due to unwanted NbO clusters present in the sputtering plasma, as discussed above. The ground state structure of NbO₂ is body centered tetragonal (bct) [47], but as seen in Figure 3, the Mott transition at 1081 K [5–7] gives rise to a local ordering of bct NbO₂. Such transition yields changes in the electronic structure (band gap filling) [48] and hence all physical and chemical properties are altered. It is accompanied by the dimerization of Nb atom pairs along the c axis (in the [001] direction), which are disordered in the pristine bct structure, that restore the local symmetry in the rutile structure. The conventional cell of bct NbO₂ with 32 formula units is thus reduced to only 2 in rutile NbO₂ [5–7]. However, the precise underlying atomic mechanisms are still not clear. Nevertheless, it is worth noting that the Mott transition temperature of NbO₂ can be affected by alloying or doping [32,49] and photons [21]. Moreover, strain may influence the transition temperature [50], but it is very often overlooked or even neglected.

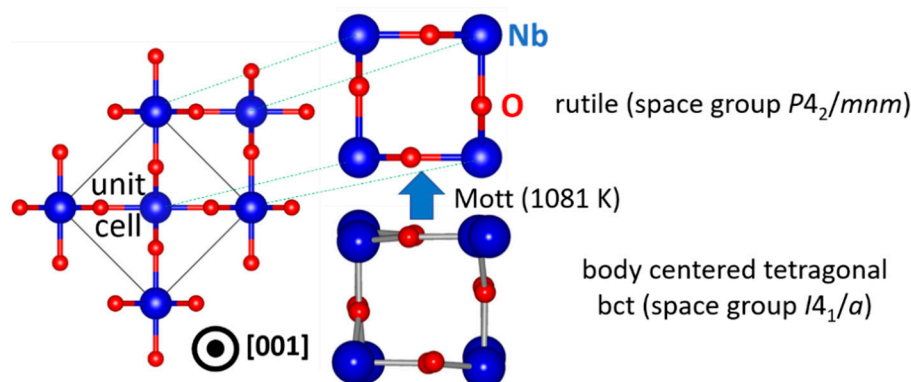


Figure 3. Mechanism of the Mott transition in NbO₂. Symmetry breaking (disordered atomic positions in bct NbO₂) is disabled at elevated temperatures where the rutile structure is stabilized.

Memristor is a high-performance non-volatile memory device that stores information in the form of electrical resistance [51]. There are cation and anion type of memristors [51], whereby NbO₂ belongs to the latter class. A lower valence state of Nb in NbO₂ than in Nb₂O₅ gives rise to oxygen migration, which is an analogue of an electron motion in a semiconductor. A non-linear behavior of the electrical resistance in NbO₂ memristors is enabled by the Mott topological transition [23–25] from high resistance bct to low resistance rutile. Hence, a detailed atomistic understanding of the Mott transition in NbO₂ is a prerequisite and necessary to advance memristor devices based thereon. Other phase change memory devices include amorphous-crystalline transition materials, such as Ge–Sb–Te alloys [52,53]. Hence, it would be exciting to explore amorphous-crystalline transitions in NbO₂ for memory applications, but this has not been exploited so far.

After addressing the nucleation and growth aspects as well as the key structural features driving the Mott transition in NbO₂, nanostructuring is addressed. Nanostructures exhibit striking, new physical and chemical properties as well as enable many cutting-edge applications [54,55]. For example, electron mobility is considerably altered in nanostructures [56]. Essentially any application pertaining to large surface areas benefits from nanostructuring, such as memory, energy generation and storage, microelectronics, food packaging and health industry, to name but a few [54,55]. Various nanostructures are known, ranging from nanorods (nanowires), nanorings, nanotubes, nanoslices (nanoplatelets) and nanoribbons, to nanoshells [54,55]. However, nanoslices have been investigated to a considerably less extent than other nano counterparts. They can be perceived as a thick adaptation of graphene [57], which is an exciting 2D model system that offers a tremendous potential for novel applications.

While NbO₂ nanorods [11], as in the case of isostructural [58,59] and RuO₂ [60–62], seem to be common, NbO₂ nanoslices [10] are less explored. NbO₂ nanoslices were synthesized by thermal oxidation [10], while NbO₂ nanorods were formed by hot-filament metal-oxide vapor deposition [11]. Both synthesis techniques are close to thermodynamic equilibrium and the samples were grown under similar conditions, but the structure evolution is drastically different as magnetron sputtering (see Figure 4) gives rise to nanoslices [22]. DFT has been employed to elucidate the underlying growth mechanisms. For the NbO₂(110) surfaces, nanoslices are more stable [22], while nanorods are more stable than nanoslices for NbO₂(001) [22]. A correlation to Nb–O clusters obtained in sputtering plasmas is still not established, but it may have relevance based on the hypothesis that large clusters act as nucleation sites for RuO₂ nanorods [60–62]. Furthermore, Nb₂O₅ forms nanobelts [63] and nanotubes [64], but it is not known if such nanostructures are feasible for NbO₂.

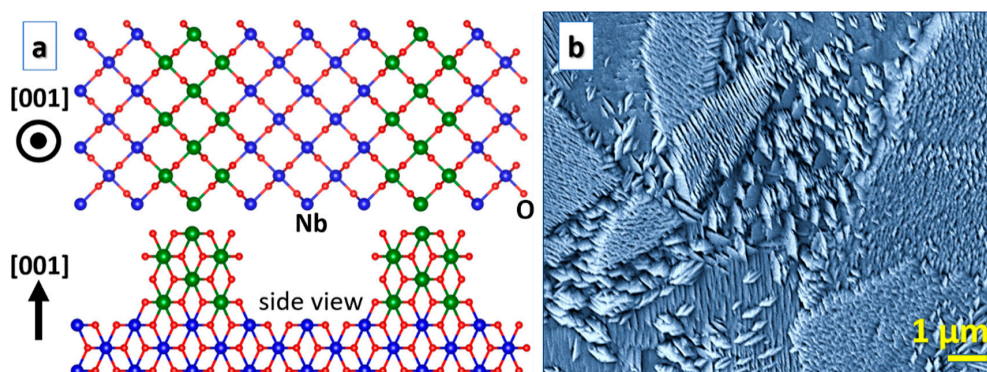


Figure 4. NbO₂ nanoslices: (a) A theoretical model; (b) a secondary electron microscopy image of a corresponding sample (a micrograph of an equivalent sample published in the literature [22]).

3. Electrical Properties

Besides memory applications, NbO₂ exhibits a huge potential for renewable energy generation and storage, enabling carbon neutral technologies. The notion of a net zero carbon footprint in conjunction with cheap energy sources is supported with thermoelectrics. Thermoelectric devices directly convert heat into electricity without CO₂ emission [65,66]. However, due to the relatively low efficiency of such devices, applications are limited to off-grid uses (e.g., unmanned remote facilities and cathodic protection of pipelines), powering space probes and satellites, waste heat recovery, as well as cooling [65,66]. Strategies to enhance the efficiency ($ZT = S^2 \sigma T / \kappa$) at a temperature T involve maximizing the Seebeck coefficient (S) and electrical conductivity (σ), while minimizing the thermal conductivity (κ) [65,66].

The behavior of the Seebeck coefficient of NbO₂ is still controversial. Figure 5 shows the Seebeck coefficient and power factor ($S^2 \sigma$) data for NbO₂ compared with other oxide systems. Crystalline and amorphous NbO₂ exhibit an increasing trend in the absolute value of the Seebeck coefficient as a function of temperature reaching approx. $-200 \mu\text{V K}^{-1}$ at 900 K according to Music et al. [13] and Backhaus-Ricoult et al. [14]. The amorphous samples outperform the crystalline ones, which is consistent with the generic notion put forward by Nolas et al. [67]. According to DFT results, this behavior is related to band gap filling [13], which is a common physical origin of the Seebeck coefficient enhancement [68]. However, these Seebeck coefficient data (trends) are inconsistent with the work of Roberson et al. [15]. This conundrum remains unresolved (see Figure 5). Nevertheless, all the Seebeck coefficient data converge at about 900 K, indicating that NbO₂ thermoelectric devices certainly perform well at high temperatures.

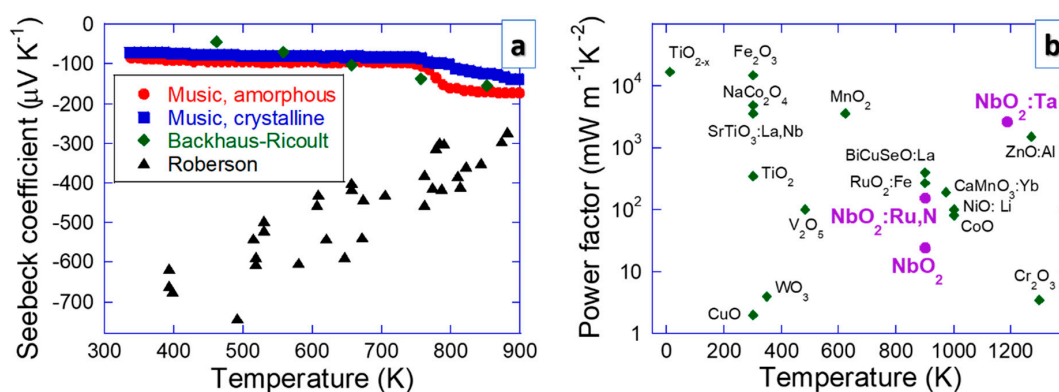


Figure 5. The electrical properties, including (a) the Seebeck coefficient (Music et al. [13], Backhaus-Ricoult et al. [14], Roberson et al. [15]) and (b) power factor data, for NbO₂ compared with other oxide systems [67–84]. The power factor is a product of the squared Seebeck coefficient and electrical conductivity.

Using DFT, more than 20 elements were studied to find candidates that could outdo the absolute value of the Seebeck coefficient of amorphous NbO₂ [85,86]. Comparing the measured power factor ($S^2\sigma$) of NbO₂ with other oxides, including isostructural TiO_{2-x} [69], TiO₂ [70], MnO₂ [71] and RuO₂:Fe [72], as well as Fe₂O₃ [73], NaCo₂O₄ [74], SrTiO₃:La,Nb [75], V₂O₅ [76], WO₃ [77], CuO [78], BiCuSeO:La [79], ZnO:Al [80], CaMnO₃:Yb [81], NiO:Li [82], CoO [83] and Cr₂O₃ [84] (see Figure 5), it is evident that NbO₂:Ta performs better than ZnO:Al [80], which is the major oxide competitor in the high temperature range. This is exciting since Nb is less toxic than Zn, proving a good alternative.

It is clear that the electrical conductivity (up to 30 kS m⁻¹ at 1100 K [14]) is high enough to enable efficient thermoelectric NbO₂ devices (see Figure 5) and the Frenkel-Poole conduction (anion vacancy mediated) mechanism appears to be of relevance [87]. Other phenomena pertaining to conductivity have been less treated. For instance, ionic conductivity can readily be detrimental in several applications. Oxygen diffusion is relevant for memristors, hydrogen for fuel cells and Li for use in Li ion batteries. In the case of thermoelectric devices, which are frequently exposed to elevated temperatures, diffusion can also be relevant since there are many interfaces in commercial systems (e.g., metallic contacts). Even though the Mott transition is a diffusion-less process (see Figure 3), interfaces to other layers may affect it (e.g., intermixing with Ti from a TiN layer was reported to lower the Mott transition temperature in NbO₂ [30]). Most of the research along these lines was carried out for Li ion batteries. The activation energy for Li diffusion in NbO₂ with W additions (NbO₂:W) is 0.1–0.3 eV [88], allowing for a specific capacity up to 225 mAhg⁻¹ in pristine NbO₂ [8,9] as well as in NbO₂:W [88]. The theoretical capacity of 429 mAhg⁻¹ in NbO₂ has not yet been reached [9]. It might be enhanced by increasing the electrical conductivity [89], an effort also conducive to thermoelectric devices. It also seems that NbO₂ show potential for redox flow batteries [90]. Further studies of alloying/doping and nanostructuring may be beneficial for batteries.

4. Thermal Properties

A property remaining to be tackled to fully describe thermoelectric devices is thermal conductivity. The thermal conductivity data have been obtained just recently. NbO₂(001) and NbO₂(110) surfaces exhibit the value of 3.0 and 2.9 W m⁻¹ K⁻¹ [91], respectively (see Figure 6). Upon nanostructuring of amorphous NbO₂ by multilayering with Ta-Ni-O, it can further be reduced to 0.6 W m⁻¹ K⁻¹ [45], which is desired for thermoelectric devices to increase the efficiency (ZT).

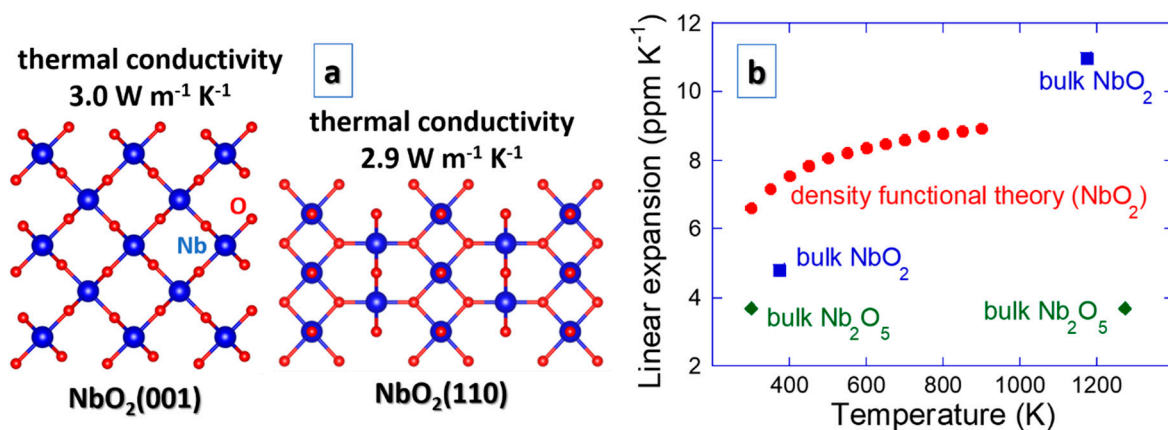


Figure 6. Thermal properties of NbO₂, including (a) thermal conductivity for two orientations [91] and (b) linear coefficient of thermal expansion obtained theoretically [92] and experimentally [20]. Due to a lack of other values, a comparison is made with the available expansion data on Nb₂O₅ [93].

Thermal management of functional materials, including thermal stress, thermal fatigue and thermal shock [38], is often overlooked or ignored even though it can easily lead to

fracture and ultimately failure. For instance, thermoelectric devices do not comprise any movable parts, but cyclic thermal loading can give rise to thermal fatigue, a secondary physical property. Thermal expansion is an integral part of thermal stress, thermal fatigue and thermal shock [38], but such data are not often available, especially not for thin films. Figure 6 contains the linear coefficient of thermal expansion data for NbO₂ obtained theoretically [92] and experimentally [20]. Due to a lack of other literature values, a comparison is made with the available thermal expansion data on Nb₂O₅ [93], pointing out that the general trends for NbO₂ are sound. However, some improvements for the NbO₂ data may be possible as theoretical and measured slopes are not entirely within the expected margins. An overlooked incentive for scattering of the thermal expansion data may be its grain size dependence [94].

Other thermal properties, such as heat capacity, are less explored. In the evaluation of binary Nb–O phase diagrams, it is accepted that the isobaric molar heat capacity of NbO₂ is in the order of 55 J mol^{−1} K^{−1} at room temperature [47], which is relatively high for solids. However, it is not known if and how the heat capacity is affected by nanostructuring or other factors (e.g., strain). Clearly, much more work on the thermal properties of NbO₂ is needed.

5. Mechanical Properties

Mechanical properties are certainly secondary properties for memory and energy related applications of NbO₂, but equivalent to the thermal expansion data discussed above they are central for thermal stress, thermal fatigue and thermal shock [38]. Hence, such aspects cannot be ignored in more realistic design endeavors of novel devices. First, elastic properties are addressed, as compiled in Figure 7. Owing to the tetragonal symmetry (*P4₂/mmm*), the rutile structure exhibits seven independent elastic constants, which along with their temperature and pressure dependence have been investigated by means of ultrasonic wave velocity measurements [95–98]. The reported data are generally consistent between the different references and at room temperature the elastic constants are $C_{11} = 433$ GPa, $C_{12} = 93$ GPa, $C_{13} = 173$ GPa, $C_{33} = 388$ GPa, $C_{44} = 94$ GPa and $C_{66} = 57$ GPa, whereas C_{16} for all practical purposes can be considered negligible [95]. The DFT [92] and bulk (the Voigt–Reuss–Hill average) [95] data for the elastic (Young’s) modulus of NbO₂ differ only by 4%. The available thin film values are not straightforward to compare with. The crystalline thin film is porous [99] and the amorphous sample contains Ta [85]. Moreover, the penetration depth during the nanoindentation experiments was 15–20% for pure NbO₂ thin films [99] and 10% for NbO₂ with Ta additions [85]. This measuring inconsistency is of relevance for the comparison of mechanical properties, but as of yet there are no systematic studies to gain more insights. Nevertheless, it seems that the elastic modulus of NbO₂ is quite high, being 64% of the value of sapphire which is a well-known stiff and hard material [100]. Such a high value can be rationalized by strongly hybridized Nb 5*d*–O 2*p* states [5]. In the light of these findings, it seems that reduced thermal stresses (product of thermal expansion, elastic modulus and boundary conditions), which can be achieved by minimization of elastic modulus, are feasible through the employment of amorphous and/or porous (or nanostructured) NbO₂.

Characterization of further mechanical properties of NbO₂ is a rather uncharted territory compared to other more commonly considered rutile oxides, e.g., TiO₂. Using the elasticity data presented above, the Debye temperature can be derived to be 597 K at low temperature, reaching ~590 K at room temperature [96,97]. Furthermore, the Cauchy pressure [101] is positive with $C_{13} - C_{44} = 79$ GPa and $C_{12} - C_{66} = 36$ GPa, indicating that a ductile response of NbO₂ may be expected, but little is known about its yield properties. Except for some measurements on sputtered films [99], there is a lack of experimental data regarding hardness for NbO₂, which is critical for, e.g., wear resistance. This emphasizes the need to explore such properties. For thin and porous films, the nanohardness values have been measured to correspond to 6 GPa [99], which most likely is an underestimation of that for compact NbO₂. Based on the Voigt–Reuss–Hill averages of the elastic constants

in conjunction with the empirical relation between the bulk and shear moduli and Vickers hardness by Chen et al. [102], it can be estimated to be 8 GPa. Although this theoretical estimate is uncertain, it is comparable to that of rutile TiO_2 [103], which has been classified as 6–6.5 on the Mohs hardness scale.

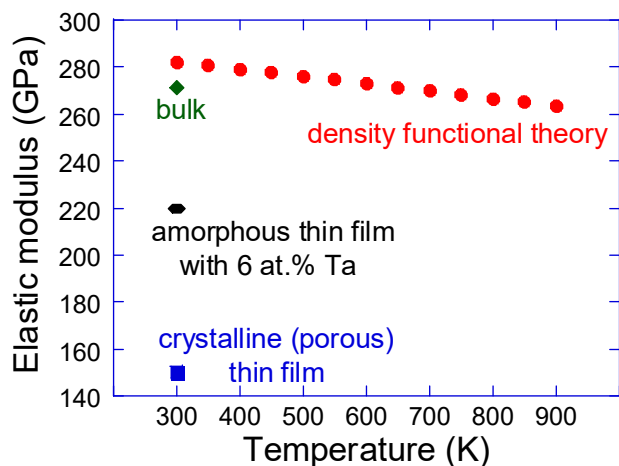


Figure 7. Elastic (Young's) modulus as a function of temperature. Density functional theory data for ideal NbO_2 [92] are compared with the bulk value [95] as well as crystalline [99] and amorphous [85] thin films. It should be noted that the crystalline thin film is porous [99] and the amorphous sample contains Ta [85], making the comparison less straightforward.

The impact that dislocations can have on physical properties, such as transport properties, of rutile transition metal oxides is well-documented [104]. However, the available literature on NbO_2 is scarce and would from both mechanical and physical perspectives benefit from further investigations. In terms of plasticity of other rutile structures, edge dislocations have been known to exist on $\{100\}$, $\{101\}$ and $\{110\}$ planes [105–108]. Experiments have shown that the slip activated systems to accommodate plastic deformation correspond to the $\{101\}\langle 10\bar{1}\rangle$ and $\{100\}\langle 0\bar{1}0\rangle$ type slip systems [105,106]. Based on results from nanoindentation experiments of TiO_2 single crystals, a directional dependence of the activated slip planes has been observed, where indentation onto (001) surfaces yields activation of all four $\{101\}\langle 10\bar{1}\rangle$ slip systems, while for the (100) surface only two of the $\{101\}\langle 10\bar{1}\rangle$ slip systems in tandem with $\{100\}\langle 0\bar{1}0\rangle$ are activated [108]. Due to intersection of slip planes for the former, the dislocation motion is generally inhibited, which indicates an increased hardening for (001) surfaces [108]. Hence, many mechanical properties are still unexplored for NbO_2 , including the physical origin thereof.

6. Summary and Outlook

NbO_2 is an emerging binary oxide with many exciting cutting-edge applications, such as memory as well as energy generation and storage devices, owing to an amalgam of its physical and chemical properties. In the present work, transport, thermal and mechanical properties are reviewed with respect to the electronic structure. Sputtering plasmas contain NbO , NbO_2 and NbO_3 clusters, influencing nucleation and growth of NbO_2 . They adsorb strongly, whereby unwanted NbO clusters likely lead to a growth disruption and recurring nucleation, which may be of relevance for nanostructuring (formation of nanorods and nanoslices). Low temperature bct NbO_2 undergoes the Mott transition at 1081 K, where pairs of Nb atoms dimerize along the c axis, stabilizing rutile NbO_2 . The Mott transition yields changes in the electronic structure (band gap filling), alerting all physical and chemical properties. These structural changes are primarily used in memristors. Beside memory applications, NbO_2 exhibits a huge potential for renewable energy generation and storage, enabling carbon neutral technologies. One example is found within thermoelectric devices, chiefly governed by the Seebeck coefficient. However, there are reports with opposing

trends thereof as a function of temperature. Nevertheless, all the Seebeck coefficient data converge to about $-200 \mu\text{V K}^{-1}$ at 900 K so that at least at this high temperature NbO₂ thermoelectric devices certainly perform well. Electrical conductivity is high enough to enable efficient thermoelectric NbO₂ devices, but research on its ionic conductivity, including oxygen for memristors, hydrogen for fuel cells and Li for use in Li ion batteries, seems to be at its infancy. Most of the research along these lines has been carried out for Li ion batteries, but their theoretical capacity has not yet been reached. Thermal management of functional materials, including thermal stress, thermal fatigue and thermal shock, is often overlooked or ignored even though it can easily promote fracture and subsequent failure. NbO₂ exhibits relatively low thermal expansion, but high elastic modulus, which can be attributed to strong Nb–O hybridization. To minimize the thermal stress, elastic modulus should be reduced, which seems to be possible in amorphous and nanostructured NbO₂. Plasticity of NbO₂ is yet to be explored.

The future of NbO₂ thin film devices is indeed very promising, but there are many issues that should be tackled both by DFT and experimentation. Many applications should further be addressed, including, e.g., fuel cells. It is often ignored that most of the physical and chemical properties are dependent on the loading conditions and microstructure, e.g., strain and grain size. These factors generally affect the electronic structure and all physical and chemical properties, but studies to gain insights into such behavior are still at infancy for NbO₂. Such aspects need to be evaluated to bring insight to their impact and severity. Nanostructuring should be further explored to enable decoupling of electrical and thermal conductivity in thermoelectric devices (enhancement of *ZT*) and larger surface areas in batteries (short diffusion pathways for Li ions enabling higher charge/discharge rates). Although NbO₂ forms nanorods and nanoslices, it remains to be seen if other nanostructures, such as nanobelts and nanotubes, can be formed to trigger further applications. Commercial devices often include many layers besides the key functional materials (e.g., metallic contacts), which is often overlooked in fundamental studies. This means that multiple interfaces must be explored and the interplay with point and extended defects, such as dislocations. Finally, interaction with non-ideal environments (e.g., atmosphere, biological tissue, etc.) should be explored for the purpose of enabling novel multifunctional applications.

Author Contributions: D.M. conceived the manuscript. All authors contributed to the evaluation and interpretation of the published data in previous works. The manuscript was primarily written by D.M. with extended inputs from A.M.K. and P.A.T.O. All authors have read and agreed to the published version of the manuscript.

Funding: This research received no external funding.

Institutional Review Board Statement: Not applicable.

Informed Consent Statement: Not applicable.

Data Availability Statement: Data sharing is not applicable to this article.

Conflicts of Interest: The authors declare no conflict of interest.

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